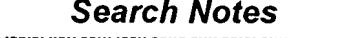


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/706,050	LEE ET AL.	
	Examiner	Art Unit	
	HOAN C. NGUYEN	2871	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner